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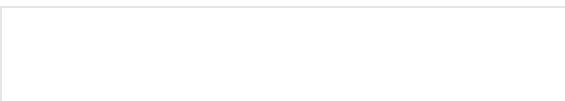
SAR Test exclusion documentation according to FCC KDB 447498

Report identification number: 1-4905/22-01-05 Exclusion (FCC)

contains the module with the following certification numbers	
FCC ID	OKY12115610A01A

This test report is electronically signed and valid without handwritten signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Document authorised:



Alexander Hnatovskiy
Lab Manager
Radio Communications & EMC



Marco Sciglano
Testing Manager
Radio Communications & EMC

EUT technologies:

Technologies:	Max. declared cond. AVG Power	Max. measured EIRP @ 10m ¹⁾	Antenna gain
NFC 125 kHz	22.08 dBm (=161.4mW)	33.2 dB μ V (Peak) = - 51.57 dBm	< 0 dBi
NFC 13.56 MHz	23.37 dBm (=217.125mW)	44.9 dB μ V (Peak) = -39.87 dBm	< 0 dBi
BT LE 2450	2.62 dBm (=1.83mW)	- 3.85 dBm ³⁾	< 0 dBi

NOTE:

The measured PEAK EIRP @10m proofs that the EUT antenna gain is far below 0dBi and that considering the max. declared output power is by far larger than the EIRP. Conducted values will be used for the RF exposure calculation. EIRP values are for information only.

The following table shows the max. declared Peak values and duty corrections for NFC 125 kHz / 13.56 MHz and BT LE:

Technology	Max. decl. cond. Peak power: [dBm] ⁴⁾	Duty cycle ²⁾ [%]	Max. declared cond. AVG Power [dBm]
NFC 125 kHz	200 mW ⁵⁾	80.7	161.4 mW
NFC 13.56 MHz	1125 mW	19.3	217.125 mW
BT LE ³⁾	3.98 mW	46.0	1.83 mW

¹⁾ Pictures of the measurement are added in Annex A of this document.

²⁾ The duty cycles can be found in Annex B of this document.

³⁾ BT LE result provided by manufacturer (Datasheet for Silicon Labs BGM220S)

⁴⁾ Extracts from the documentation of the max. peak conducted values can be found in Annex C of this document

⁵⁾ Max. output power for the 125kHz circle is 200mW according customer declaration.

Collocation:

Note: NFC 125 kHz and 13.56 MHz can be active at the same time, but only with interleaving of packages switched on board level. That means that they don't transmit at the same time.

Technology	Active scenario:	1	2	3	4
NFC 125 kHz / 13.56 MHz		x		x	
BT LE		x	x		

SAR test exclusion according to KDB447498 (General RF Exposure Guidance v06)

Equation from Chapter 4.3.1: Standalone SAR test exclusion considerations page 11 and ff.

BT LE:

(1) Standalone SAR test exclusion for 100 MHz to 6 GHz at test separation distances $\leq 50\text{mm}$

$$(\text{Threshold}_{1\text{-g};10\text{-g}}) \times d_{\text{seperation}} / f^{0.5}$$

where

$\text{Threshold}_{1\text{-g};10\text{-g}}$ is 3 for 1-g; 7.5 for 10-g

$d_{\text{seperation}}$ is the min. test separation distance; 5mm is used if the distance is less

f is the RF channel transmit frequency

The table below gives the calculated maximal power that could be used for source based time averaged conducted or radiated power, adjusted for tune up tolerance. If this is at or below the calculated value the DUT is exempted from SAR evaluation.

frequency [MHz]	d _{seperation} [mm]	Threshold _{1-g}	Powerlimit [mW]	P _{max-declared}		Exclusion
				[dBm]	[mW]	
2450.00	5	3	9.58	2.62	1.83	yes

NFC:

(c) (2) Standalone SAR test exclusion below 100 MHz $< 50\text{mm}$

$$0.5 \times (\text{Threshold}_{100\text{MHz}}) \times (1 + \log(100/f))$$

where

$\text{Threshold}_{1\text{-g};10\text{-g}}$ is 3 for 1-g; 7.5 for 10-g

f is the RF channel transmit frequency

$\text{Threshold}_{100\text{MHz},50\text{mm}}$ is $\text{Threshold}_{1\text{-g};10\text{-g}} \times d / f^{0.5}$; with $f = 100\text{MHz}$ and $d=50\text{mm}$

The table below gives the calculated maximal power that could be used for source based time averaged conducted power, adjusted for tune up tolerance. If this is below the calculated value SAR testing is excluded.

frequency [MHz]	Threshold _{1-g;10-g}	Threshold _{100MHz,50mm}	Powerlimit [mW]	P _{max-declared}		Exclusion
				[dBm]	[mW]	
0.13	3	474.34	925.70	22.08	161.4	yes
13.56	3	474.34	442.97	23.37	217.3	yes

Collocation:**Overview:**

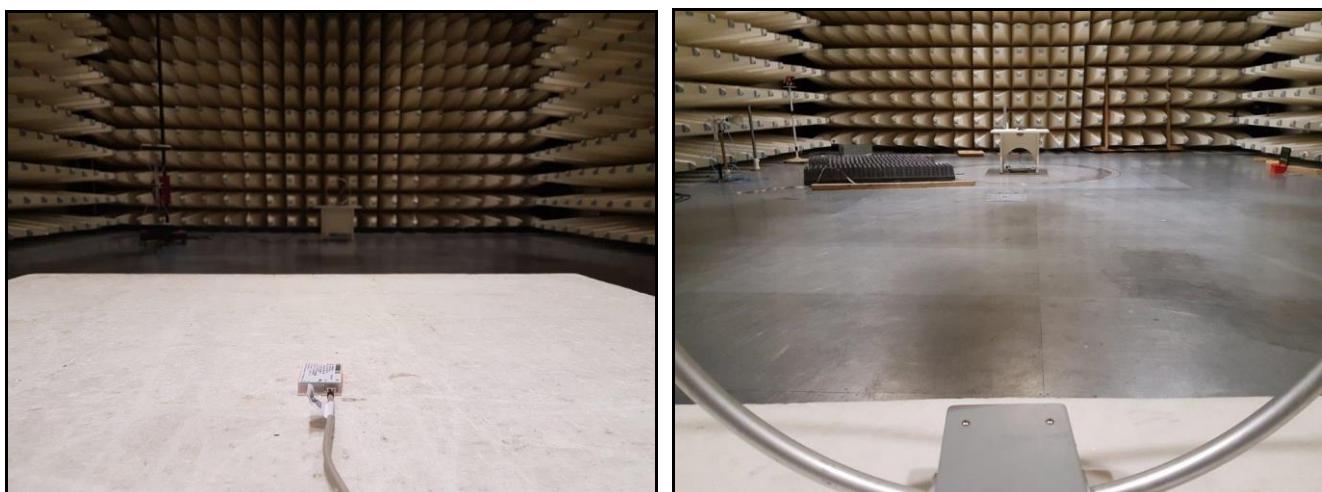
Technology, [MHz]	NFC, 125 kHz	NFC, 13.56 MHz	BT LE
Exemption based on	SAR exclusion		
Limit EIRP [mW]:	925.7	442.97	9.58
Result EIRP [mW]:	161.4	217.3	1.83
Limit-Exhaustion [%]	17.4	49.1	19.1
Collocated percentage [%] [NFC 13.56 MHz + BT LE]	68.2		
Verdict:	Pass		

This prediction demonstrates the following:

The power density levels for FCC that are larger than the minimum safety-distances stated above, are below the maximum levels allowed by regulations.

Annex A:

Pictures of the EIRP measurement for 125 kHz / 13.56 MHz with 10m distance

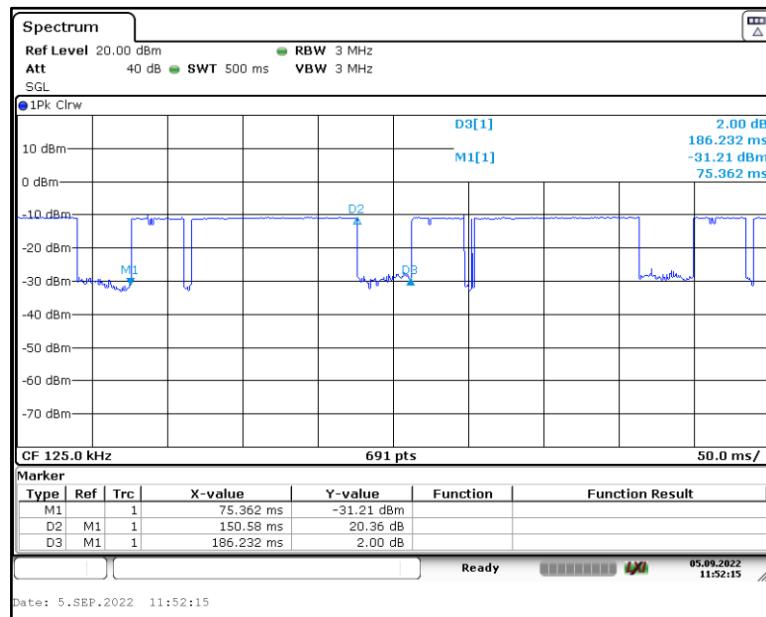


Loop-Antenna: EMCO 6502A (Correction factors @ 125 kHz +10.4 dB, @ 13.56 MHz +9.5 dB)



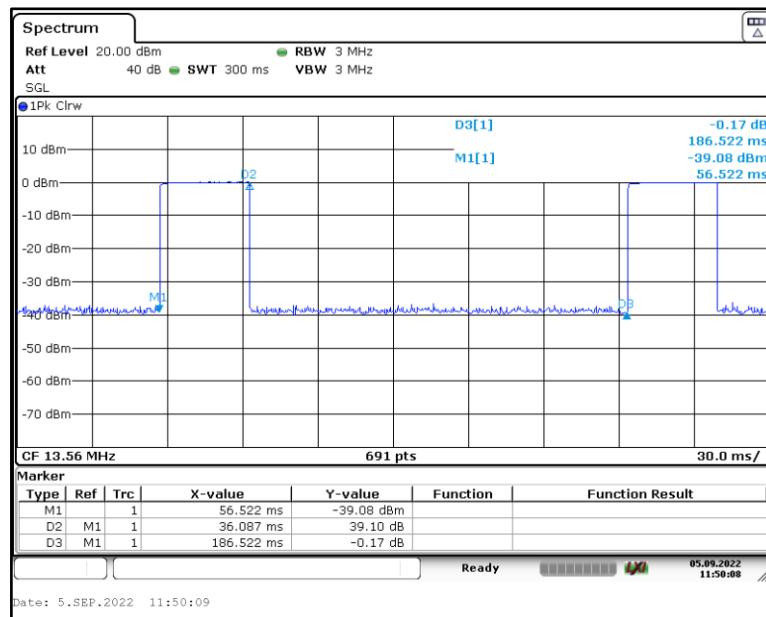
Annex B: Duty cycles

Duty cycle 125 kHz of the EUT:



Duty Cycle 80.7%

Duty cycle 13.56 MHz of the EUT:



Duty Cycle 19.3%

Annex C: Conducted values from datasheets**13.56 MHz (PN5180 – NXP Semiconductors)****11. Limiting values**

Table 105. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DD(PVDD)}	PVDD supply voltage	-	-	3.6	V
V _{DD(TVDD)}	TVDD supply voltage	-	-	4.6	V
V _{ESD}	electrostatic discharge voltage	Human Body Model (HBM); 1500 Ω, 100 pF; JESD22-A114-B	-	1500	V
T _{stg}	storage temperature	no supply voltage applied	-55	+150	°C
P _{tot}	total power dissipation	in still air with exposed pins soldered on a 4 layer JEDEC PCB	-	1125	mW
T _{j(max)}	maximum junction temperature	-	-	150	°C